

| | | | |
|-----------------------------------|---------------------------------------|---|-------------|
| Notice of References Cited | Application/Control No. 10/711,150 | Applicant(s)/Patent Under Reexamination ANDERSON ET AL. | |
| | Examiner Eric A. Gates | Art Unit 3722 | Page 1 of 1 |

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|--------------------|----------------|
| * | A | US-4,174,591 A | 11-1979 | Dupre et al. | 451/103 |
| * | B | US-4,889,290 A | 12-1989 | Koffsky et al. | 241/36 |
| * | C | US-5,456,022 A | 10-1995 | McLeod et al. | 34/77 |
| * | D | US-5,775,542 A | 07-1998 | Field, Arnold | 222/146.5 |
| * | E | US-6,021,969 A | 02-2000 | Schmitt et al. | 241/171 |
| * | F | US-6,112,504 A | 09-2000 | McGregor et al. | 53/417 |
| * | G | US-6,569,217 B1 | 05-2003 | DeMarco, Thomas M. | 55/324 |
| * | H | US-6,571,838 B1 | 06-2003 | Chiang, Pei-Lieh | 144/252.1 |
| * | I | US-2003/0131571 A1 | 07-2003 | Demarco, Thomas M. | 55/324 |
| | J | US- | | | |
| | K | US- | | | |
| | L | US- | | | |
| | M | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | O | | | | | |
| | P | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | |
| | T | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | U | |
| | V | |
| | W | |
| | X | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.